Application/Control No. Applicant(s)/Patent Under Reexamination 09/921,019 VELEZ ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Jonathan S. Crepeau 1746 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name MM-YYYY Country Code-Number-Kind Code US-Α US-В US-С US-D Ε US-US-F US-G US-Н US-Τ J US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY **WIPO** Ν WO 89/09497 10-1989 JP 01-260764 10-1989 (with abstract) Japan 0 JP 01-105473 04-1989 (with abstract) Japan Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W ť

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.